Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/671,861	LEE ET AL.
Examiner	Art Unit
Alex Liew	2624

	SEARCHED		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
382/141-152 limited to text search	2/26/2007	AL
209/517 limited to text search	2/26/2007	AL
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